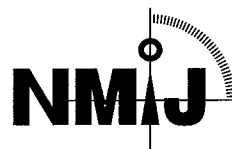


Member State of OIML
Japan



OIML Certificate No
R76/1992-JP1-06.01

OIML CERTIFICATE OF CONFORMITY

Issuing authority

Name: National Institute of Advanced Industrial Science and Technology
Address: 1-3-1, Kasumigaseki, Chiyoda-ku, TOKYO, 100-8921, Japan
Person responsible: Hiroyuki Yoshikawa

Applicant

Name: TANITA CORPORATION
Address: 14-2, 1chome, Maeno-cho, Itabashi-ku, Tokyo, 174-8630, Japan

Manufacturer of the certified pattern

Name: TANITA AKITA CORPORATION
Address: 28-1, Shimotamogizoe, Horiminai, Aza, Daisen-shi, Akita-ken,
014-0113, Japan

Identification of the certified pattern:

Type PW-630MA
Further characteristics see page 2

This certificate attests the conformity of the above-mentioned pattern (represented by the samples identified in the associated test report) with the requirements of the following Recommendation(s) of the International Organization of Legal Metrology (OIML):

R76-1, edition 1992, including amendment 1 (1994),
for accuracy class **III**

This certificate relates only to the metrological and technical characteristics of the pattern of the instrument concerned, as covered by the relevant OIML International Recommendation(s).

This certificate does not bestow any form of legal international approval.

Member State of OIML
Japan



OIML Certificate No
R76/1992-JP1-06.01



The conformity was established by tests described in the associated test report
N° 05-03/R76 (56 pages).

The Issuing Authority

The OIML member



Dr. H. Yoshikawa
President
Jan 17 2006

A handwritten signature in cursive script, appearing to read 'Y. Miki'.

Dr. Y. Miki
Jan 17 2006

Characteristics:

Type	PW-630MA
Accuracy class	III
Max	300 kg
$e \geq$	0.1 kg
$d \geq$	0.01 kg
n	3000
Min	2 kg
Tare-balancing range	$T \leq 150$ kg
Temperature range	0 °C / 35 °C

Important note: Apart from the mention of certificate's reference number and the name of the OIML Member State in which the certificate was issued, partial quotation of the certificate or of the associated test report is not permitted, though they may be reproduced in full.